

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Philip Marriott Art Unit : 2881
Serial No. : 09/787,358 Examiner : Anthony Quash
Filed : May 15, 2001 Conf. No. : 7859
Title : MEANS FOR REMOVING UNWANTED IONS FROM AN ION TRANSPORT
SYSTEM AND MASS SPECTROMETER

Mail Stop Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form.
Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent
literature are enclosed.

Respectfully submitted,

Date: August 16, 2001

Jennifer A. Zanolco
Reg. No. 54,563

Customer No. 26181
Fish & Richardson P.C.
500 Arguello Street, Suite 500
Redwood City, California 94063
Telephone: (650) 839-5070
Facsimile: (650) 839-5071

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 14544-002001	Application No. 09/787,358
Information Disclosure Statement by Applicant (Use several sheets if necessary)		Applicant Philip Marriott	
		Filing Date May 15, 2001	Group Art Unit 2881

U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
	AQ	Douglas et al., "Elemental Analysis with a Microwave-Induced Plasma/Quadrupole Mass Spectrometer System", Analytical Chemistry, Vol. 53, No. 1, 37-41, January 1981
	AR	Tanner et al., "Gas and Ion Dynamics of a Three-Aperature Vacuum Interface for Inductively Coupled Plasma-Mass Spectrometry", Applied Spectroscopy, Vol. 48, No. 11, 1373-1378, 1994
	AS	
	AT	

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	